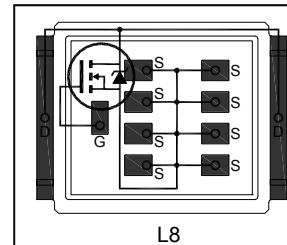


- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Allowed up to Tjmax
- Lead Free, RoHS Compliant and Halogen Free
- Automotive Qualified \*

$V_{(BR)DSS}$	60V
$R_{DS(on)}$ typ.	1.1mΩ
	1.5mΩ
$I_D$ (Silicon Limited)	345A
$Q_g$	183nC


Applicable DirectFET™ Outline and Substrate Outline ①

SB	SC			M2	M4		L4	L6	L8	
----	----	--	--	----	----	--	----	----	----	--

**Description**

The AUIRF7749L2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging technology to achieve exceptional performance in a package that has the footprint of a D-Pak (TO-252AA) and only 0.7mm profile. The DirectFET™ package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note [AN-1035](#) is followed regarding the manufacturing methods and processes. The DirectFET™ package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET™ packaging platform coupled with the latest silicon technology allows the AUIRF7749L2 to offer substantial system level savings and performance improvement specifically in motor drive, DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve ultra low on-resistance per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRF7749L2	DirectFET™ Large Can	Tape and Reel	4000	AUIRF7749L2TR

**Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
$V_{DS}$	Drain-to-Source Voltage	60	V
$I_D$ @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ④	345	A
$I_D$ @ $T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ④	243	
$I_D$ @ $T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ③	36	
$I_D$ @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Package limit) ④	375	
$I_{DM}$	Pulsed Drain Current ⑤	1380	
$P_D$ @ $T_C = 25^\circ\text{C}$	Power Dissipation ④	341	W
$P_D$ @ $T_A = 25^\circ\text{C}$	Power Dissipation ③	3.8	
$E_{AS}$	Single Pulse Avalanche Energy (Thermally Limited) ⑥	315	mJ
$E_{AS}$ (Tested)	Single Pulse Avalanche Energy ⑥	714	
$I_{AR}$	Avalanche Current ⑤	See Fig. 16, 17, 18a, 18b	A
$E_{AR}$	Repetitive Avalanche Energy ⑤		mJ
$T_P$	Peak Soldering Temperature	270	°C
$T_J$	Operating Junction and Storage Temperature Range	-55 to + 175	

HEXFET® is a registered trademark of International Rectifier.

\*Qualification standards can be found at : [www.infineon.com](http://www.infineon.com)

**Thermal Resistance**

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③	—	40	°C/W
$R_{\theta JA}$	Junction-to-Ambient ⑧	12.5	—	
$R_{\theta JA}$	Junction-to-Ambient ⑨	20	—	
$R_{\theta J-Can}$	Junction-to-Can ④⑩	—	0.44	
$R_{\theta J-PCB}$	Junction-to-PCB Mounted	—	0.5	
	Linear Derating Factor ④	2.3		W/°C

**Static Electrical Characteristics @  $T_J = 25^\circ C$  (unless otherwise specified)**

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	56	—	mV/°C	Reference to $25^\circ C, I_D = 3.0mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	1.1	1.5	mΩ	$V_{GS} = 10V, I_D = 120A$
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-8.8	—	mV/°C	
$g_{fs}$	Forward Trans conductance	185	—	—	S	$V_{DS} = 10V, I_D = 120A$
$R_G$	Internal Gate Resistance	—	1.5	—	Ω	
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	20	μA	$V_{DS} = 60V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 60V, V_{GS} = 0V, T_J = 125^\circ C$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$

**Dynamic Electrical Characteristics @  $T_J = 25^\circ C$  (unless otherwise specified)**

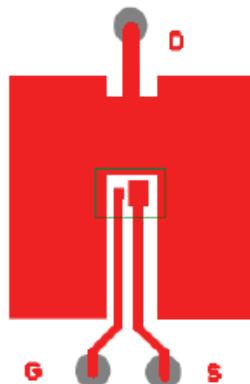
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge	—	183	275	nC	$V_{DS} = 30V$ $V_{GS} = 10V$ $I_D = 120A$
$Q_{gs1}$	Gate-to-Source Charge	—	39	—		
$Q_{gs2}$	Gate-to-Source Charge	—	19	—		
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	46	—		
$Q_{godr}$	Gate Charge Overdrive	—	79	—		
$Q_{sw}$	Switch Charge ( $Q_{gs2} + Q_{gd}$ )	—	65	—		
$Q_{oss}$	Output Charge	—	119	—	nC	$V_{DS} = 48V, V_{GS} = 0V$
$t_{d(on)}$	Turn-On Delay Time	—	29	—	ns	$V_{DD} = 30V, V_{GS} = 10V$ ⑦ $I_D = 120A$ $R_G = 1.8\Omega$
$t_r$	Rise Time	—	149	—		
$t_{d(off)}$	Turn-Off Delay Time	—	72	—		
$t_f$	Fall Time	—	88	—		
$C_{iss}$	Input Capacitance	—	10655	—	pF	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1.0 \text{ MHz}$ $V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V$
$C_{oss}$	Output Capacitance	—	1627	—		
$C_{rss}$	Reverse Transfer Capacitance	—	680	—		
$C_{oss \ eff.}$	Effective Output Capacitance	—	1959	—		

Notes ① through ⑩ are on page 11

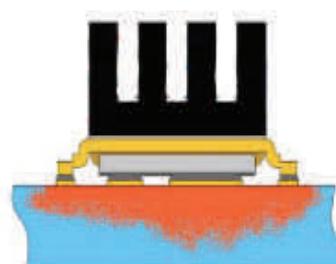
### Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	345	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ⑤	—	—	1380		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$ , $I_S = 120\text{A}$ , $V_{GS} = 0\text{V}$ ⑦
$t_{rr}$	Reverse Recovery Time	—	42	—	ns	$I_F = 120\text{A}$ , $V_{DD} = 30\text{V}$
$Q_{rr}$	Reverse Recovery Charge	—	54	—	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ⑦

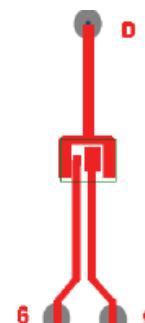
Notes ① through ⑩ are on page 11



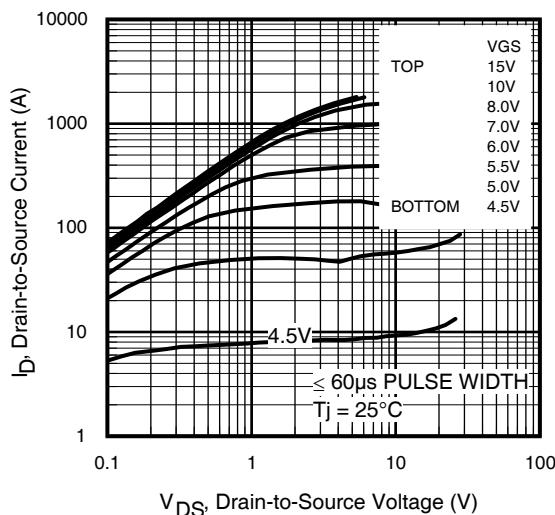
③ Surface mounted on 1 in.  
square Cu board (still air).



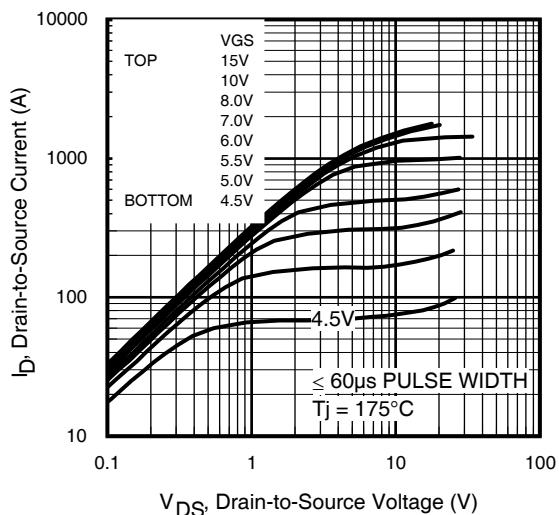
⑨ Mounted to a PCB with  
small clip heatsink (still air)



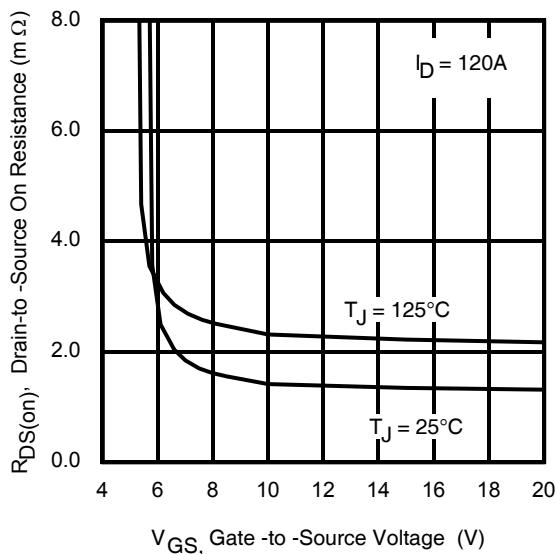
⑩ Mounted on minimum  
footprint full size board with  
metalized back and with small  
clip heatsink (still air).



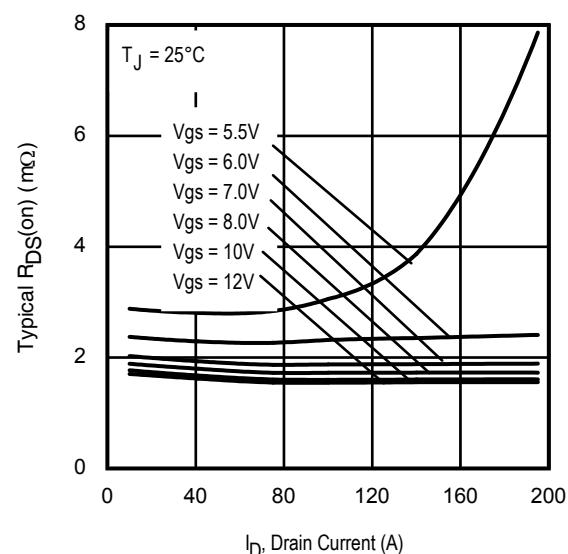
**Fig. 1** Typical Output Characteristics



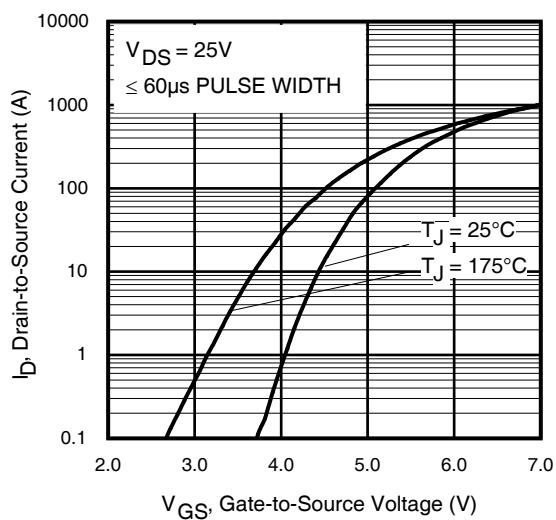
**Fig. 2** Typical Output Characteristics



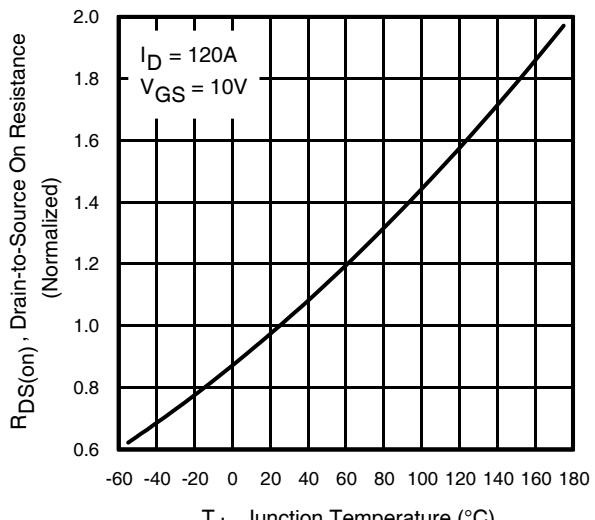
**Fig. 3** Typical On-Resistance vs. Gate Voltage



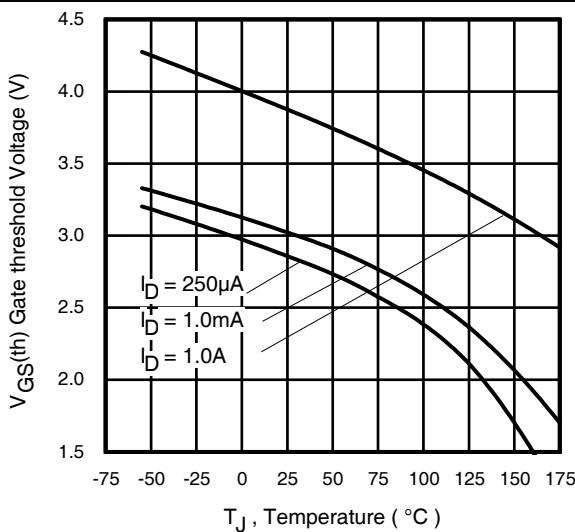
**Fig. 4** Typical On-Resistance vs. Drain Current



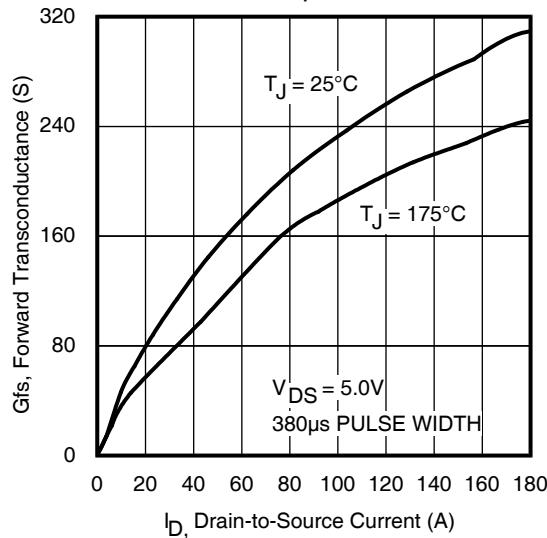
**Fig. 5.** Transfer Characteristics



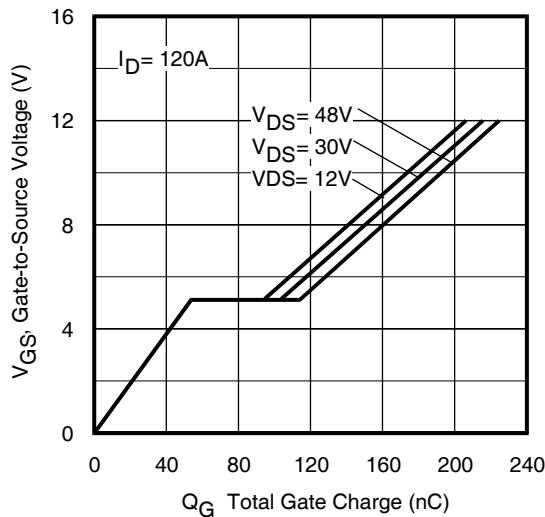
**Fig. 6.** Normalized On-Resistance vs. Temperature



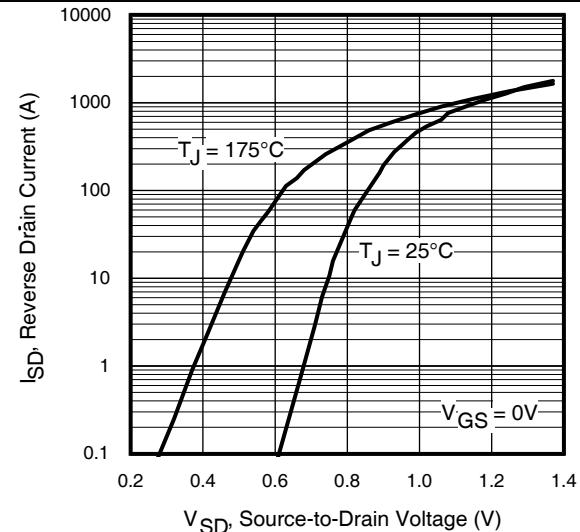
**Fig. 7** Typical Threshold Voltage vs. Junction Temperature



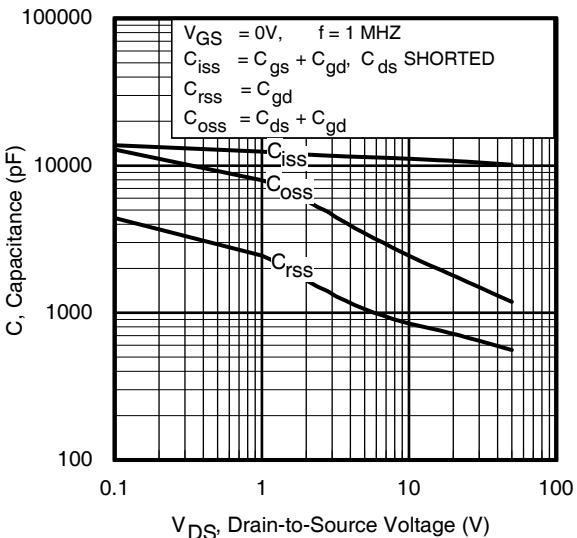
**Fig 9.** Typical Forward Trans conductance vs. Drain Current



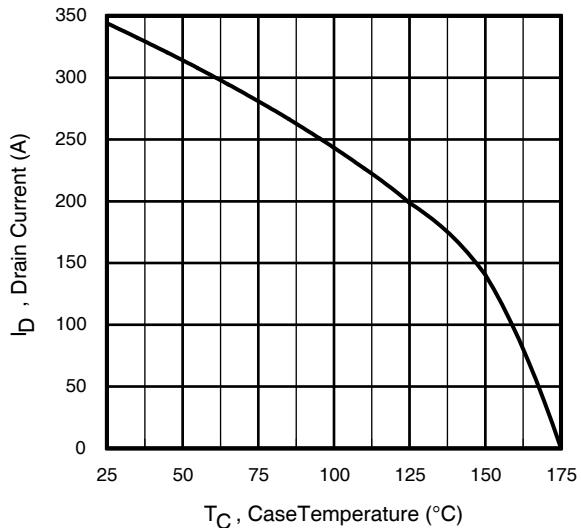
**Fig 11.** Typical Gate Charge vs. Gate-to-Source Voltage



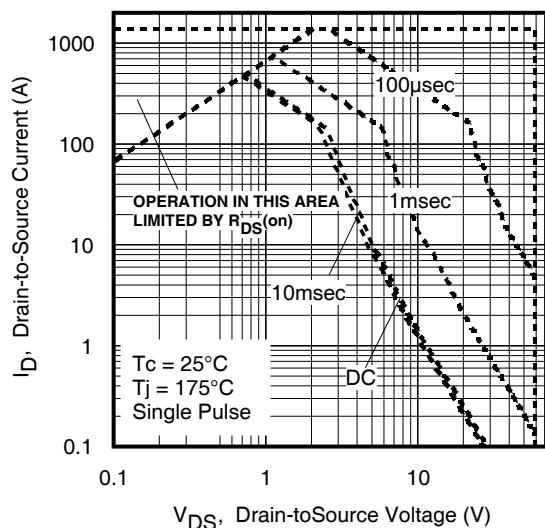
**Fig 8.** Typical Source-Drain Diode Forward Voltage



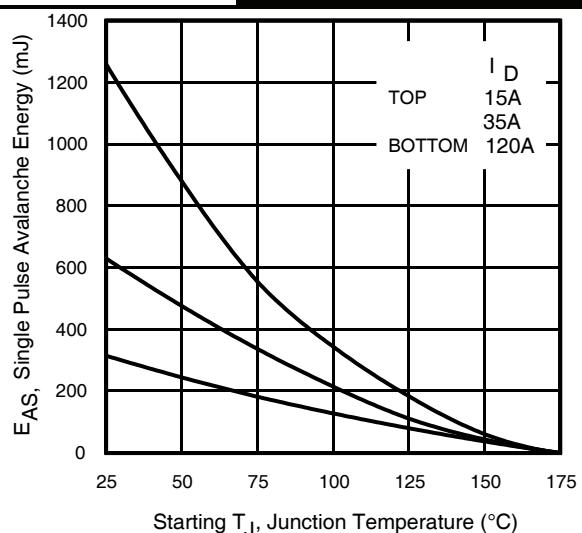
**Fig 10.** Typical Capacitance vs. Drain-to-Source Voltage



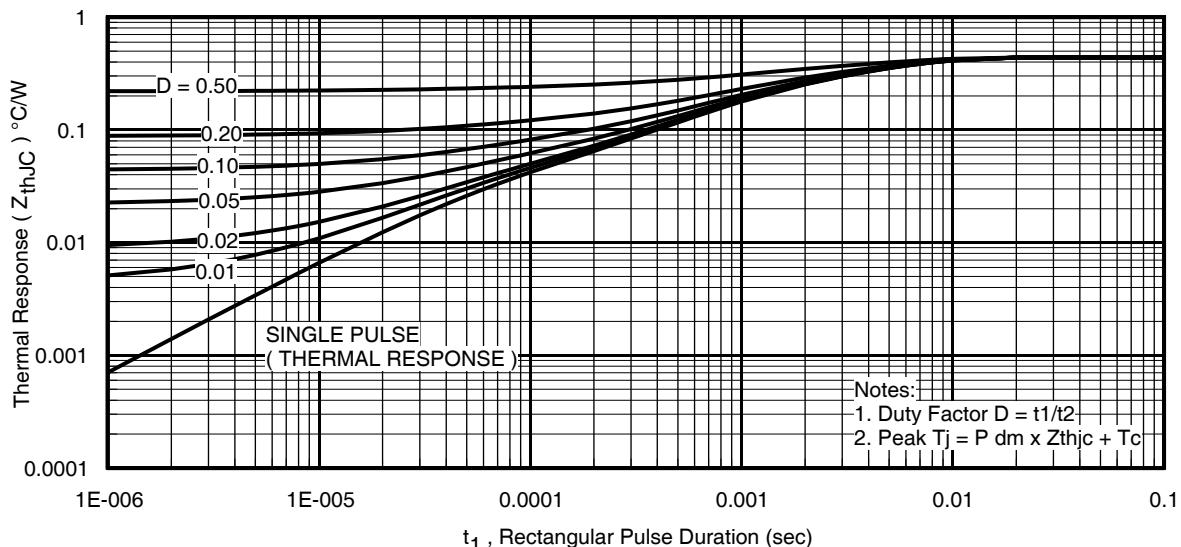
**Fig 12.** Maximum Drain Current vs. Case Temperature



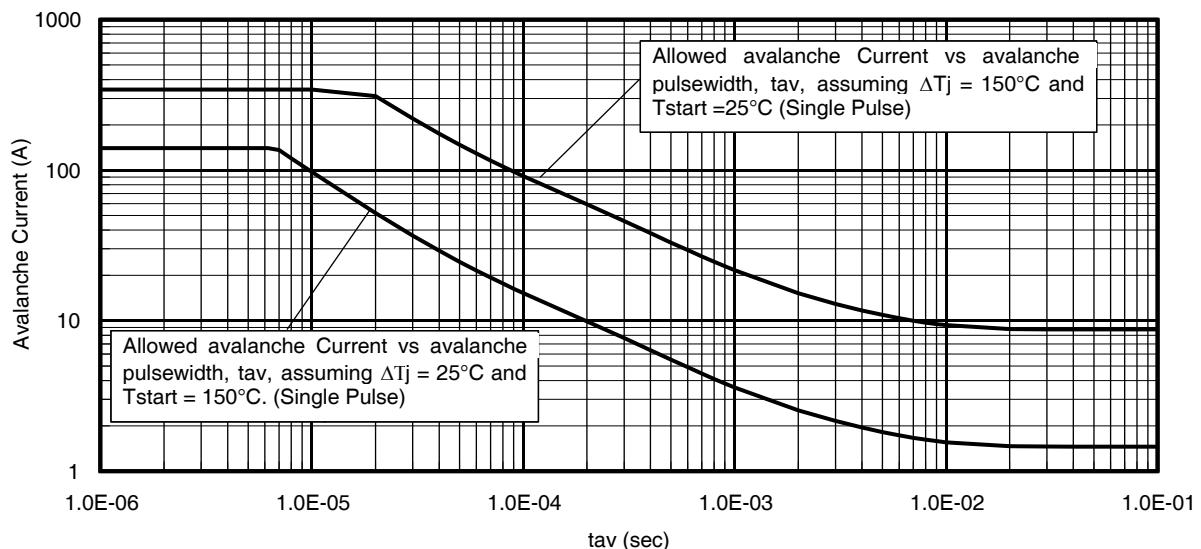
**Fig 13.** Maximum Safe Operating Area



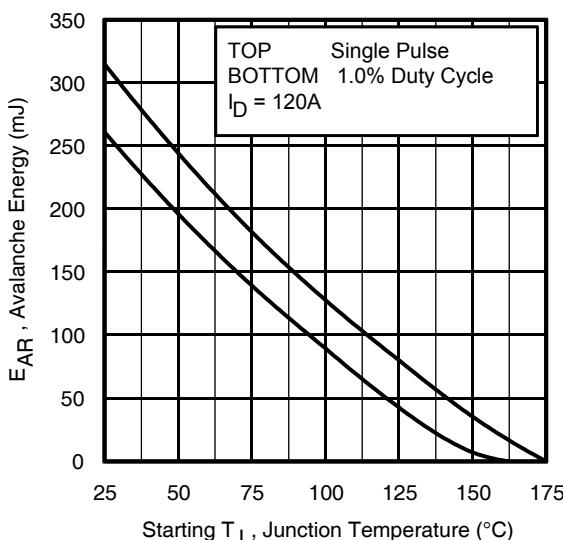
**Fig 14.** Maximum Avalanche Energy vs. Temperature



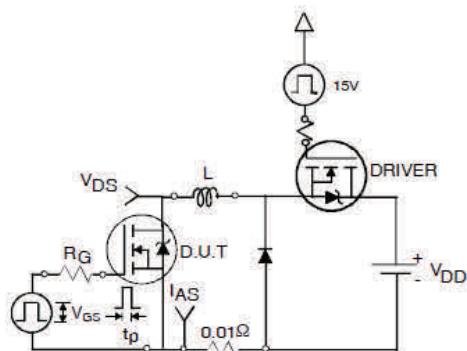
**Fig 15.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



**Fig 16.** Typical Avalanche Current vs. Pulse Width



**Fig 17.** Maximum Avalanche Energy vs. Temperature

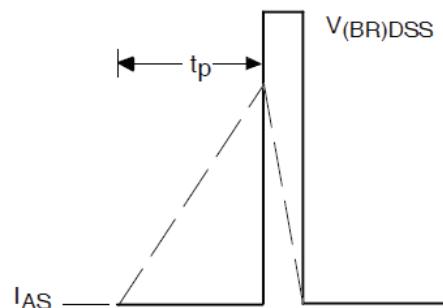


**Fig 18a.** Unclamped Inductive Test Circuit

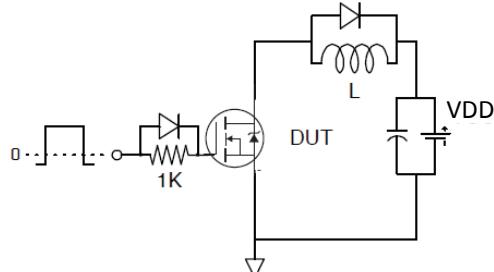
$$P_{D \text{ (ave)}} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

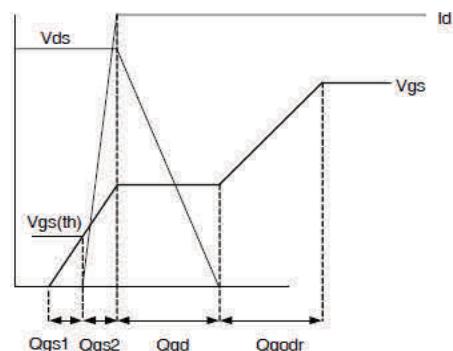
$$E_{AS \text{ (AR)}} = P_{D \text{ (ave)}} \cdot t_{av}$$



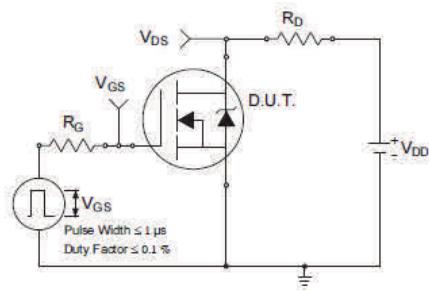
**Fig 18b.** Unclamped Inductive Waveforms



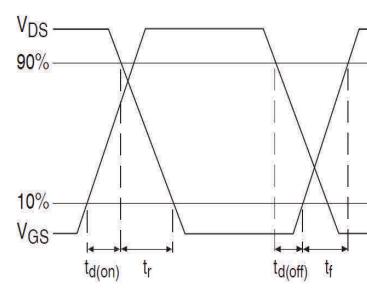
**Fig 19a.** Gate Charge Test Circuit



**Fig 19b.** Gate Charge Waveform



**Fig 20a.** Switching Time Test Circuit



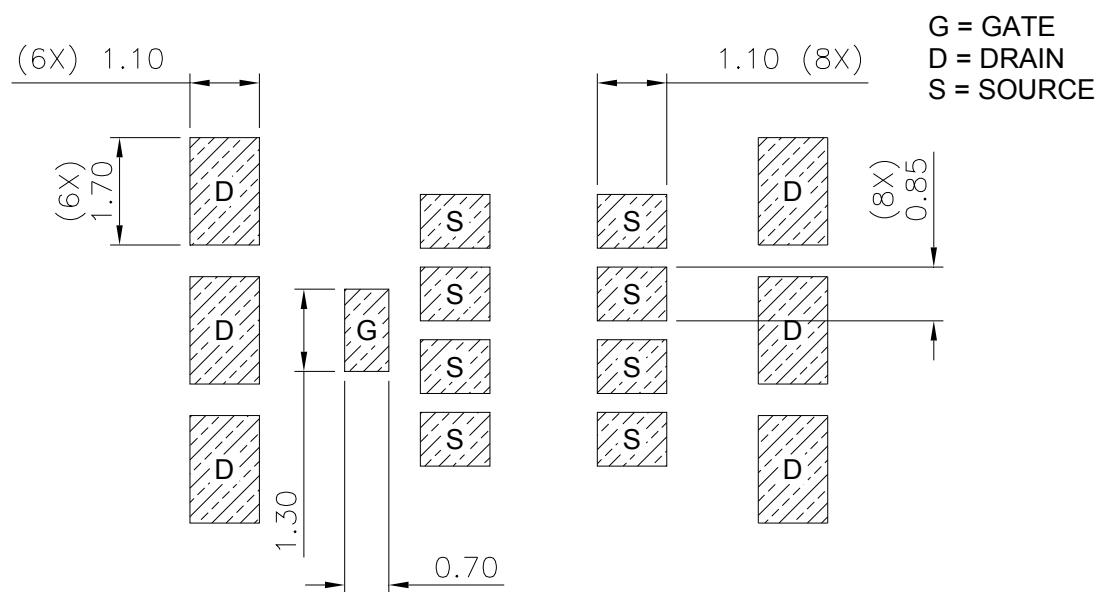
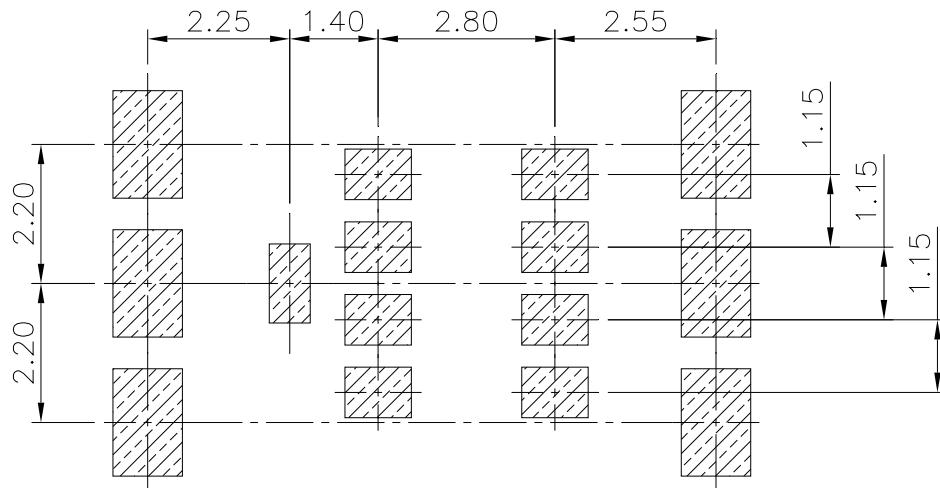
**Fig 20b.** Switching Time Waveforms

**Notes on Repetitive Avalanche Curves , Figures 16, 17:**  
**(For further info, see AN-1035 at [www.infineon.com](http://www.infineon.com))**

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
4.  $P_{D \text{ (ave)}}$  = Average power dissipation per single avalanche pulse.
5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 16, 17).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} / t_{cycle}$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 15)

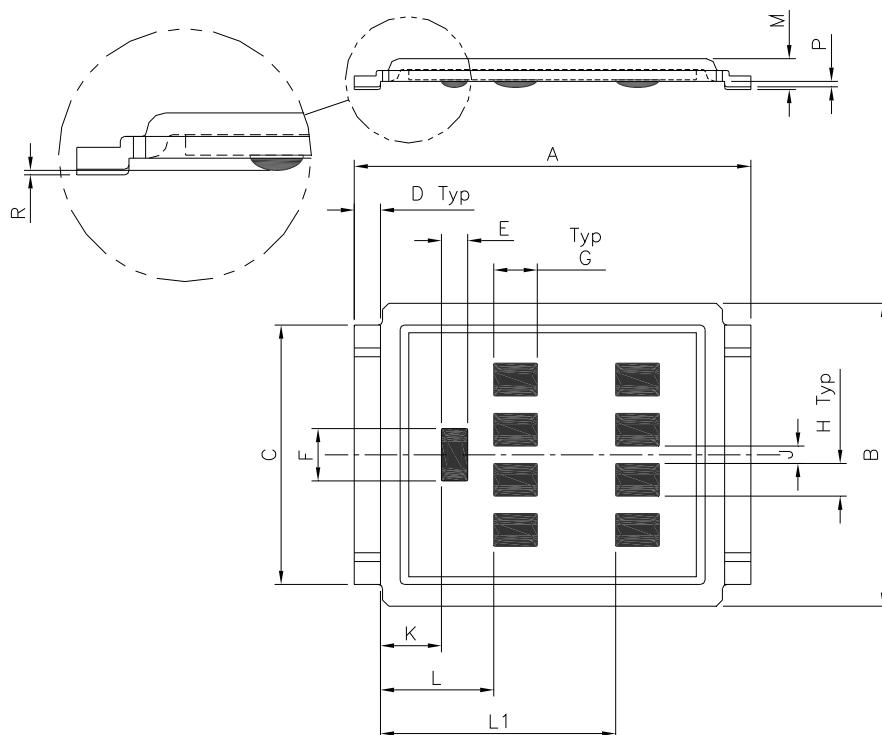
## DirectFET™ Board Footprint, L8 Outline (Large Size Can, 8-Source Pads)

Please see DirectFET™ application note [AN-1035](#) for all details regarding the assembly of DirectFET™.  
This includes all recommendations for stencil and substrate designs.



## DirectFET™ Outline Dimension, L8 Outline (Large Size Can, 8-Source Pads)

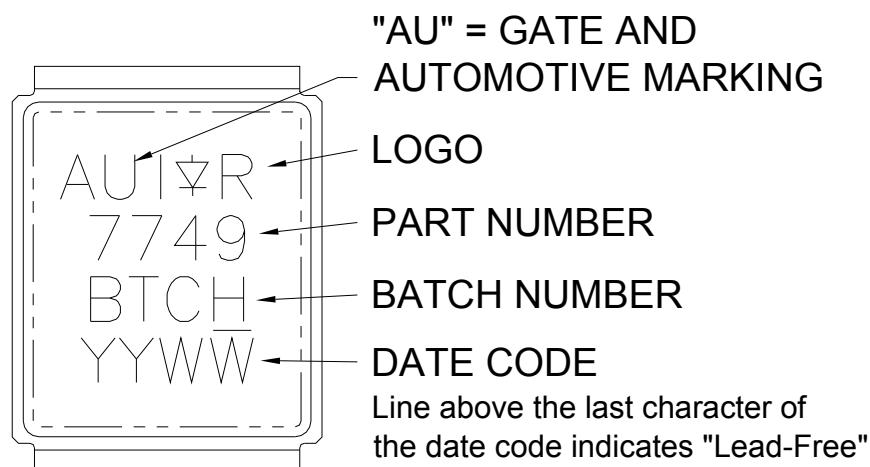
Please see DirectFET™ application note [AN-1035](#) for all details regarding the assembly of DirectFET™. This includes all recommendations for stencil and substrate designs.



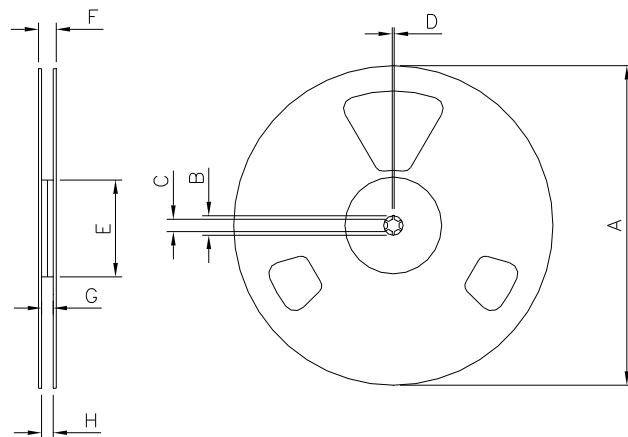
CODE	DIMENSIONS			
	METRIC	IMPERIAL	MIN	MAX
A	9.05	9.15	0.356	0.360
B	6.85	7.10	0.270	0.280
C	5.90	6.00	0.232	0.236
D	0.55	0.65	0.022	0.026
E	0.58	0.62	0.023	0.024
F	1.18	1.22	0.046	0.048
G	0.98	1.02	0.039	0.040
H	0.73	0.77	0.029	0.030
J	0.38	0.42	0.015	0.017
K	1.35	1.45	0.053	0.057
L	2.55	2.65	0.100	0.104
L1	5.35	5.45	0.211	0.215
M	0.68	0.74	0.027	0.029
P	0.09	0.17	0.003	0.007
R	0.02	0.08	0.001	0.003

Dimensions are shown in millimeters (inches)

## DirectFET™ Part Marking



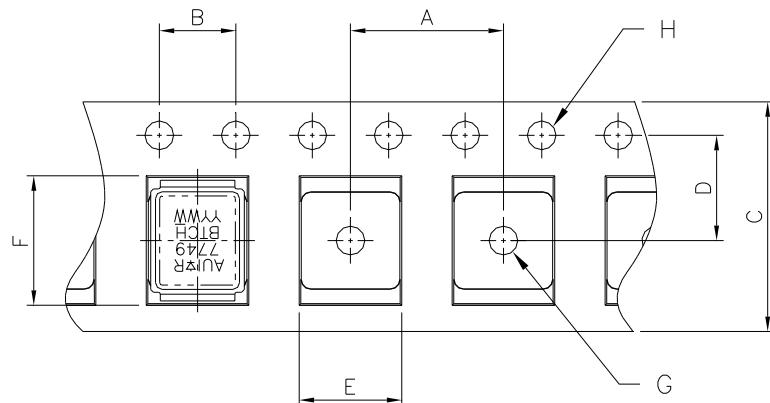
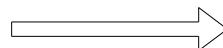
## DirectFET™ Tape &amp; Reel Dimension (Showing component orientation)



NOTE: Controlling dimensions in mm  
Std reel quantity is 4000 parts. (ordered as AUIRF7749L2TR).

REEL DIMENSIONS			
STANDARD OPTION (QTY 4000)			
	METRIC	IMPERIAL	
CODE	MIN	MAX	MIN
A	330.00	N.C	12.992
B	20.20	N.C	0.795
C	12.80	13.20	0.504
D	1.50	N.C	0.059
E	99.00	100.00	3.900
F	N.C	22.40	0.880
G	16.40	18.40	0.650
H	15.90	19.40	0.630

## LOADED TAPE FEED DIRECTION



NOTE: CONTROLLING  
DIMENSIONS IN MM

DIMENSIONS				
	METRIC		IMPERIAL	
CODE	MIN	MAX	MIN	MAX
A	11.90	12.10	0.469	0.476
B	3.90	4.10	0.154	0.161
C	15.90	16.30	0.623	0.642
D	7.40	7.60	0.291	0.299
E	7.20	7.40	0.283	0.291
F	9.90	10.10	0.390	0.398
G	1.50	N.C	0.059	N.C
H	1.50	1.60	0.059	0.063

## Qualification Information

<b>Qualification Level</b>		Automotive (per AEC-Q101)	
Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		DirectFET2 L-CAN	MSL1
ESD	Machine Model	Class M4 (+/- 800V) <sup>†</sup>	AEC-Q101-002
	Human Body Model	Class H2 (+/- 4000V) <sup>†</sup>	AEC-Q101-001
<b>RoHS Compliant</b>		Yes	

† Highest passing voltage.

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the Direct FET™ Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④  $T_C$  measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- ⑥ Limited by  $T_{Jmax}$ , Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.044\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 120\text{A}$ .
- ⑦ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑧ Used double sided cooling, mounting pad with large heat sink.
- ⑨ Mounted on minimum footprint full size board with metalized back and with small clip heat sink.
- ⑩  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .

**Revision History**

Date	Comments
10/11/2016	<ul style="list-style-type: none"><li>• Changed datasheet with "Infineon" logo –all pages.</li><li>• Corrected typo on Absolute Maximum Ratings table –from "<math>V_{GS}</math>" to "<math>V_{DS}</math>" on page 1.</li><li>• Added disclaimer on last page.</li></ul>

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